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185

194

267

Study on Quantitative Analysis of Carbon and Nitrogen in Stoichiometric θ -Fe₃C and

Determination of Mass Attenuation Coefficients of Th, U, Np, and Pu for Oxygen Ka

MATERIALS SCIENCE APPLICATIONS

Jun Takahashi, Kazuto Kawakami and Yukiko Kobayashi

 γ -Fe₄N by Atom Probe Tomography

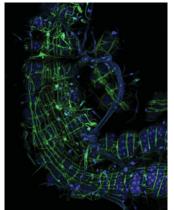
X-Rays Using an Electron Microprobe

Philipp Pöml and Xavier Llovet

Enhancement of the Temporal Resolution of Fluorescent Signals Acquired by the Confocal Microscope	
Arsenii Y. Arkhipov, Eduard F. Khaziev, Andrey I. Skorinkin, Ellya A. Bukharaeva and Dmitry V. Samigullin	20
Locally Condensed Water as a Solution for In Situ Wet Corrosion Electron Microscopy Majid Ahmadi, Frans D. Tichelaar, Andreas Ihring, Michael Kunze, Sophie Billat, Zahra Kolahdouz Esfahani and Henny W. Zandbergen	21
Versatile Homebuilt Gas Feed and Analysis System for <i>Operando</i> TEM of Catalysts at Work	
Milivoj Plodinec, Hannah C. Nerl, Ramzi Farra, Marc G. Willinger, Eugen Stotz, Robert Schlögl and Thomas Lunkenbein	220
Introducing and Controlling Water Vapor in Closed-Cell <i>In Situ</i> Electron Microscopy Gas Reactions	
Kinga A. Unocic, Franklin S. Walden, Nelson L. Marthe, Abhaya K. Datye, Wilbur C. Bigelow and Lawrence F. Allard	229
High-Efficiency Three-Dimensional Visualization of Complex Microstructures via Multidimensional STEM Acquisition and Reconstruction	
Kevin G. Field, Benjamin P. Eftink, Chad M. Parish and Stuart A. Maloy	24
Reflections on the Analysis of Interfaces and Grain Boundaries by Atom Probe Tomography	
Benjamin M. Jenkins, Frédéric Danoix, Mohamed Gouné, Paul A.J. Bagot, Zirong Peng, Michael P. Moody and Baptiste Gault	24
Field Ion Emission in an Atom Probe Microscope Triggered by Femtosecond-Pulsed Coherent Extreme Ultraviolet Light	
Ann N. Chiaramonti, Luis Miaja-Avila, Benjamin W. Caplins, Paul T. Blanchard, David R. Diercks, Brian P. Gorman and Norman A. Sanford	258

BIOLOGICAL APPLICATIONS

Confocal Analysis of the Distribution and Persistence of Sindbis Virus (TaV-GFP) Infection in Midguts of *Aedes aegypti* Mosquitoes Jason J. Saredy, Florence Y. Chim, Zoë L. Lyski, Yani P. Ahearn and Doria F. Bowers



Volume 26, Number 2

April 2020

On the Cover: Dissemination of Sindbis virus in the posterior midgut of the mosquito *Aedes aegypti*. Laser confocal microscope image shows GFP virus (green) in peristaltic gut muscles accented by nuclei (blue).

Controlled Crystallization and Transformation of Carbonate Minerals with Dumbbell- like Morphologies on Bacterial Cell Templates Chonghong Zhang, Fuchun Li, Jun Sun and Jiejie Lv	275
Connexin 43 Knockdown Induces Mitochondrial Dysfunction and Affects Early Developmental Competence in Porcine Embryos	
Kyung-Tae Shin, Zheng-Wen Nie, Wenjun Zhou, Dongjie Zhou, Ju-Yeon Kim, Sun A. Ock, Ying-Jie Niu and Xiang-Shun Cui	287
Filamentous versus Spherical Morphology: A Case Study of the Recombinant A/WSN/33 (H1N1) Virus	
Larisa V. Kordyukova, Ramil R. Mintaev, Artyom A. Rtishchev, Marina S. Kunda, Natalia N. Ryzhova, Sergei S. Abramchuk, Marina V. Serebryakova, Vladislav V. Khrustalev, Tatyana A. Khrustaleva, Victor V. Poboinev, Stanislav G. Markushin and Olga L. Voronina	297
Electron Microscopy-Based Comparison and Investigation of the Morphology of Exosomes Derived from Hepatocellular Carcinoma Cells Isolated at Different Centrifugal Speeds	
Jing-Huan Deng, Zhong-Jie Li, Zi-Xuan Wang, Ji Feng, Xue-Jing Huang and Zhi-Ming Zeng	310
A Comparative Study on the Self-Assembly of Peptide TGV-9 by <i>In Situ</i> Atomic Force Microscopy	
Yaping Li, Na Li, Lei Wang, Qinhua Lu, Xiang Ji and Feng Zhang	319
Micrographia	
Comparative Morphological Features of Syrinx in Male Domestic Fowl <i>Gallus gallus domesticus</i> and Male Domestic Pigeon <i>Columba livia domestica</i> : A Histochemical, Ultrastructural, Scanning Electron Microscopic and Morphometrical Study	
Ismail Abdel-Aziz Ibrahim, Marwa M. Hussein, Amira Hamdy and Fatma M. Abdel-Maksoud	326
Morphological, Molecular, and Pathological Appraisal of <i>Hymenolepis nana</i> (Hymenolepididae) Infecting Laboratory Mice (<i>Mus musculus</i>)	
Ebtsam Al-Olayan, Maha Elamin, Eman Alshehri, Abeer Aloufi, Zainab Alanazi, Mina Almayouf, Lamia Bakr and Rewaida Abdel-Gaber	348

BOOK REVIEW

 Roland A. Fleck and Bruno M. Humbel: Biological Field Emission Scanning Electron

 Microscopy

 Klaus Qvortrup
 363